Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/939,638	CHEN ET AL.	
Examiner	Art Unit	
Lin Ye	2615	

	SEARCHED					
Class	Subclass	Date	Examiner			
348	234 252 235	5/25/2005	LY			
	624 631	ľ	1			
	272 273					
382	300 264					
	254					
	260					
	266	4	V			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
E.A.S.T	2/22/2005	LY		